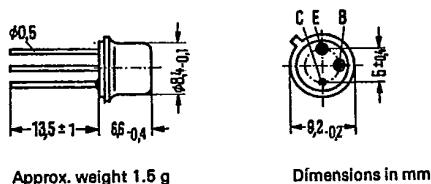


BSX 62 and BSX 63 are epitaxial NPN silicon planar transistors in TO 39 case (5 C 3 DIN 41873). The collector is electrically connected to the case. The transistors are particularly suitable for AF output stages and as a medium-power switch.

Type	Ordering code
BSX 62	Q60218-X62
BSX 62-6	Q60218-X62-B
BSX 62-10	Q60218-X62-C
BSX 62-16	Q60218-X62-D
BSX 63	Q60218-X63
BSX 63-6	Q60218-X63-B
BSX 63-10	Q60218-X63-C



Approx. weight 1.6 g

Dimensions in mm

Maximum ratings

	BSX 62	BSX 63	
Collector-emitter voltage V_{CEO}	40	60	V
Collector-emitter voltage V_{CES}	60	80	V
Emitter-base voltage V_{EBO}	5	5	V
Collector current I_C	3	3	A
Base current I_B	500	500	mA
Junction temperature T_J	200	200	°C
Storage temperature range T_{stg}	-65 to +200	-65 to +200	°C
Total power dissipation ($T_{case} \leq 25^\circ\text{C}$) P_{tot}	5	5	W

Thermal resistance

Junction to case R_{thJC}	≤ 35	≤ 35	K/W
Junction to ambient air R_{thJA}	≤ 200	≤ 200	K/W

Static characteristics ($T_{case} = 25^\circ\text{C}$)

Transistors BSX 62 and BSX 63 are grouped according to their DC current gain h_{FE} at $I_C = 1 \text{ A}$ and $V_{CE} = 1 \text{ V}$. The different groups are marked by figures of the DIN-R 5 series. Valid for the following operating points are:

Type	BSX 62	BSX 62	BSX 62	BSX 62, BSX 63			
	BSX 63	BSX 63	-				
h_{FE} group	6	10	16				
V_{CE} V	I_C A	h_{FE} I_C/I_B	h_{FE} I_C/I_B	h_{FE} I_C/I_B	V_{BE} V	$V_{CESat}^{(1)}$ V	$V_{BESat}^{(1)}$ V
1	0.1	70 (> 30)	110	180	0.72 (< 1)	-	-
1	1	63 (40 to 100)*	100 (63 to 160)*	160 (100 to 250)*	0.9 (< 1.2)	-	-
5	2	40 (> 25)	70	120	1.0 (< 1.3)	-	-
	2	-	-	-	-	0.4 (< 0.8)	1.0 (< 1.3)
	2	-	-	-	-	0.2 (< 0.7)	0.9 (< 1.2)

1) The transistor is saturated to such an extent that the DC current gain decreases to $h_{FE} = 10$.
 * AQL = 0.65%

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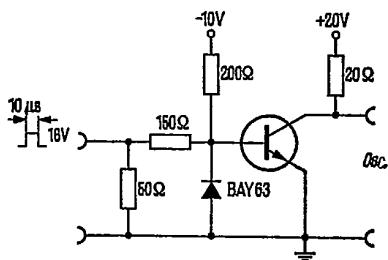
Static characteristics ($T_{amb} = 25^\circ C$)

	BSX 62	BSX 63	
Collector cutoff current ($V_{CES} = 40 V$)	I_{CES} 10 (<100)*	—	nA
Collector cutoff current ($V_{CES} = 60 V$)	I_{CES} —	10 (<100)*	nA
Collector cutoff current ($V_{CES} = 40 V; T_{case} = 150^\circ C$)	I_{CES} 10 (<100)	—	μA
Collector cutoff current ($V_{CES} = 60 V; T_{case} = 150^\circ C$)	I_{CES} —	10 (<100)	μA
Collector-emitter breakdown voltage ($I_{CE} = 100 \text{ mA}$; pulse length 200 μs; duty cycle 1%)	$V_{(BR)CEO}$ >40	>60	V
Emitter-base breakdown voltage ($I_{EB} = 10 \mu\text{A}$)	$V_{(BR)EBO}$ >5	>5	V
Collector-base breakdown voltage ($I_{CB} = 100 \mu\text{A}$)	$V_{(BR)CBO}$ >60	>60	V

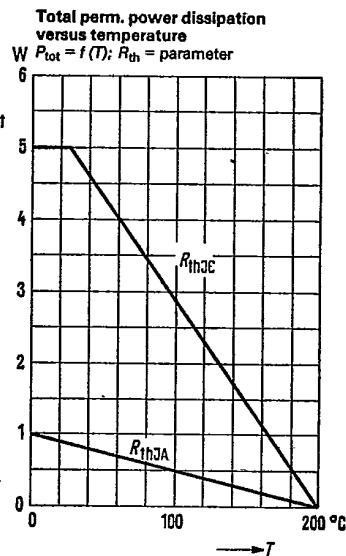
Dynamic characteristics ($T_{case} = 25^\circ C$)

Transition frequency ($I_C = 200 \text{ mA}; V_{CE} = 10 \text{ V}$)	f_T	70 (>30)	70 (>30)	MHz
Collector-base capacitance ($V_{CB} = 10 \text{ V}$)	C_{CBO}	35 (<70)	35 (<70)	pF
Switching times: (I_C approx. 1A; I_{B1} approx. $-I_{B2}$ approx. 50mA)	t_{on} t_{off}	<0.3 <1.5	<0.3 <1.5	μs μs

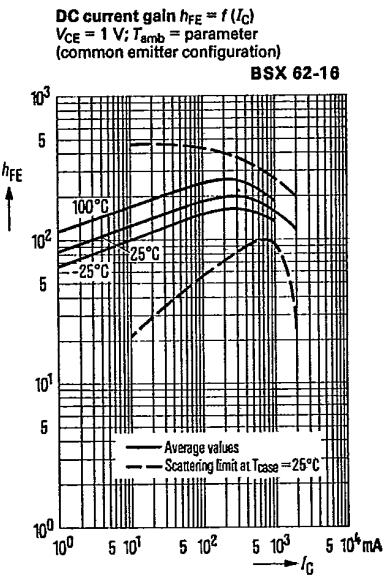
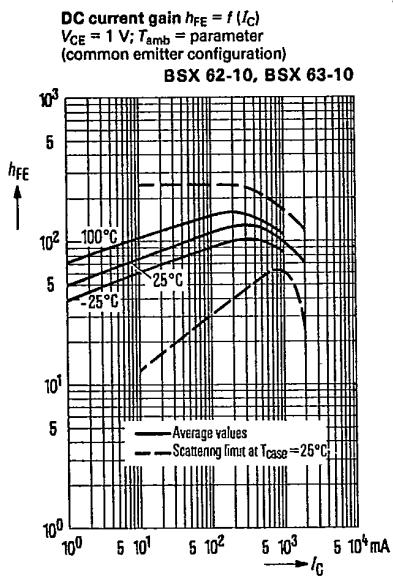
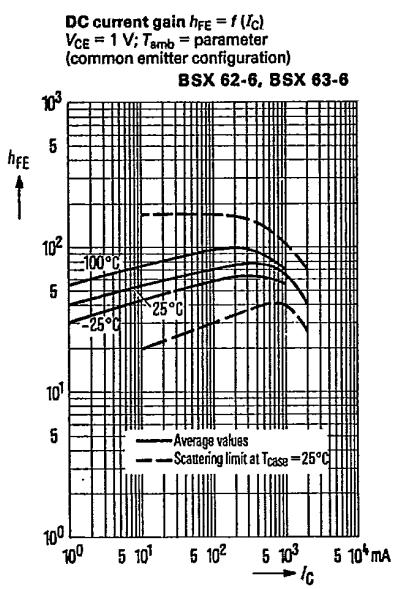
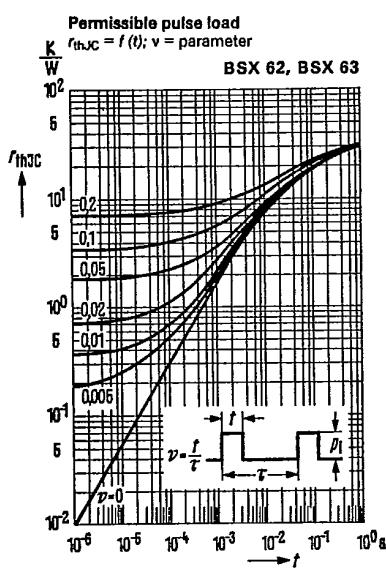
Test circuit for switching times



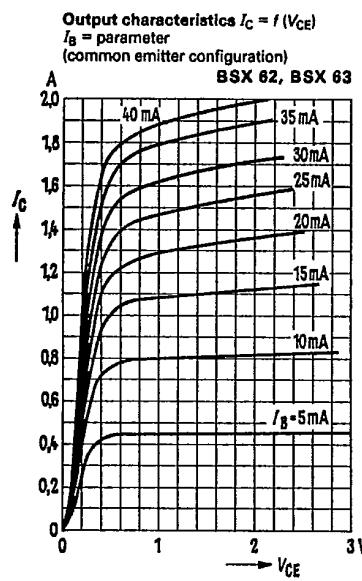
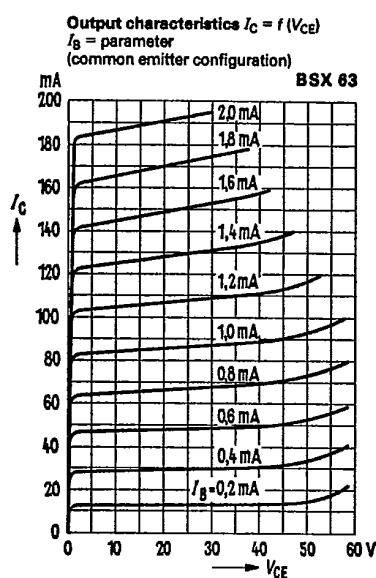
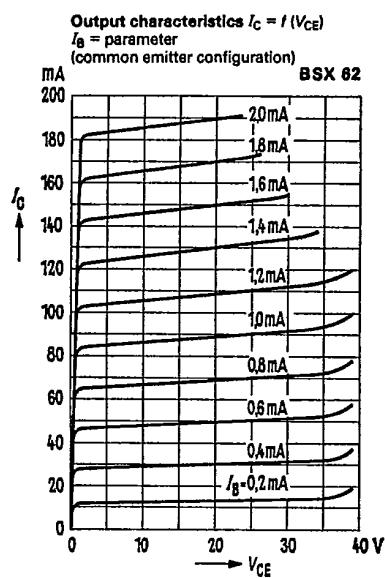
* AQL = 0.65%



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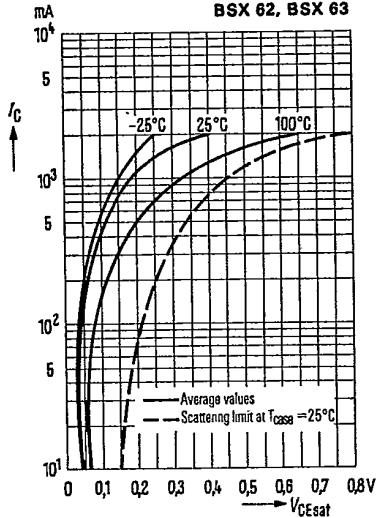
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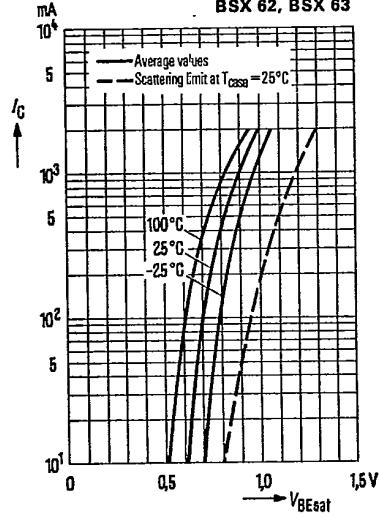
Collector-emitter saturation voltage $V_{CEsat} = f(I_c)$
 $h_{FE} = 10$; T_{amb} = parameter
 (common emitter configuration)

BSX 62, BSX 63



Collector-base saturation voltage $V_{BEsat} = f(I_c)$
 $h_{FE} = 10$; T_{amb} = parameter
 (common emitter configuration)

BSX 62, BSX 63



Collector cutoff current versus temperature $I_{CBO} = f(T_{amb})$

BSX 62, BSX 63

